

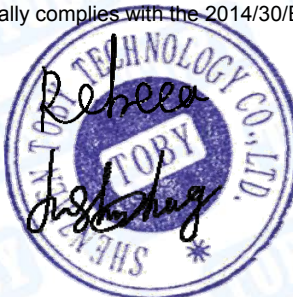
EMC Test Report

Application No. : TB161214405
Applicant :
Equipment Under Test (EUT)
EUT Name : Power bank
Model No. : SP0301
Series Model No. : N/A
Brand Name :
Receipt Date : 2016-11-30
Test Date : 2016-11-30 to 2016-12-05
Issue Date : 2016-12-05
Standards : EN55032: 2015 Class B
EN55024: 2010+A1: 2015
Conclusions : **PASS**

In the configuration tested, the EUT complied with the standards specified above
The EUT technically complies with the 2014/30/EU directive requirements

Test/Witness Engineer :

Approved & Authorized :



This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

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1. General Information

1.1. Client Information

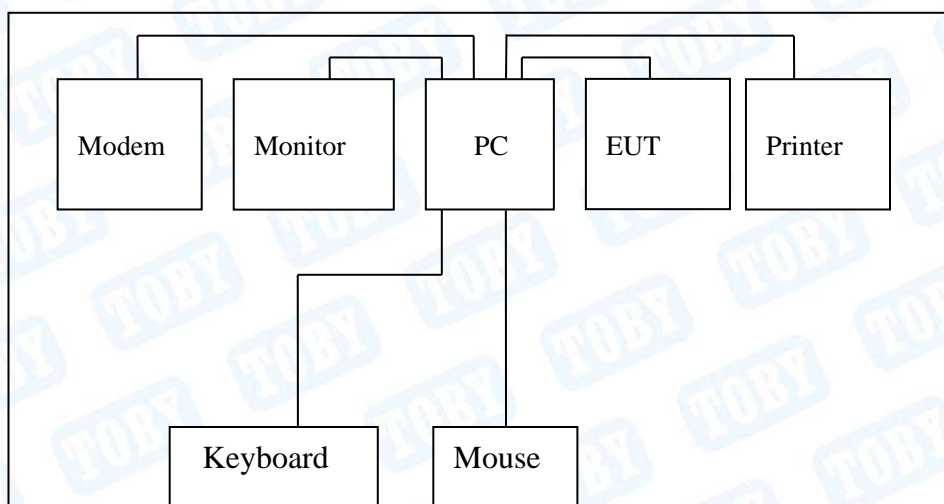
Applicant	:	
Address	:	
Manufacturer	:	
Address	:	

1.2. General Description of EUT (Equipment Under Test)

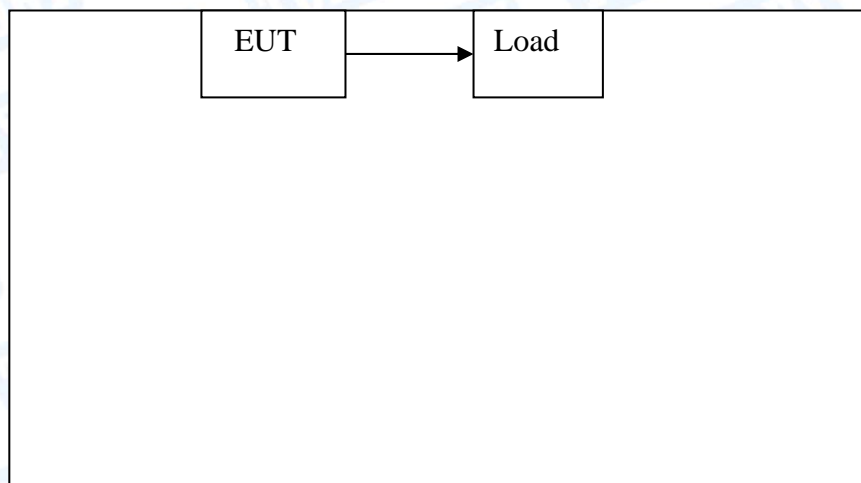
EUT Name	:	Power bank
Model No.	:	SP0301
Series Model No.	:	N/A
Brand Name	:	
Class of EUT	:	<input type="checkbox"/> Class A <input checked="" type="checkbox"/> Class B
EUT Type	:	<input checked="" type="checkbox"/> Table top <input type="checkbox"/> Floor standing <input type="checkbox"/> combination
Fx	:	N/A
Power Supply	:	Input: DC 5V/1000mA Output: DC 5V/ 1000mA Capacity:1000mAh
Remark: / Fx: Highest internal frequency.		

1.3. Block Diagram Showing The Configuration of System Tested

Model 1



Model 2



1.4. Description of Support Units

Name	Model	S/N	Manufacturer	Used “√”
Printer	HP1505n	VNF3G06957	HP	√
Modem	RX304Xv2	----	ASUS	√
LCD Monitor	E170Sc	----	DELL	√
PC	OPTIPLEX380	----	DELL	√
Keyboard	L100	U01C	DELL	√
Mouse	M-UARDEL7	----	DELL	√

1.5. Description of Operating Mode

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanning tested based on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Charging Mode
Mode 2	Discharging Mode

The EUT system operated these modes were found to be the worst case during the pre-scanning test as Following:

For EMI Test

Final Test Mode	Description
Mode 1	Charging Mode
Mode 2	Discharging Mode
For EMS Test	
Final Test Mode	Description
Mode 1	Charging Mode
Mode 2	Discharging Mode

1.6. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.7. Measurement Uncertainty

The reported uncertainty of measurement $y \pm U$, where expanded uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately 95 %.

Test	Parameters	Expanded Uncertainty (U_{Lab})	Expanded Uncertainty (U_{Cispr})
Conducted Emission	Level Accuracy: 9kHz~150kHz 150kHz to 30MHz	± 3.42 dB ± 3.42 dB	± 4.0 dB ± 3.6 dB
Radiated Emission	Level Accuracy: 9kHz to 30 MHz	± 4.60 dB	N/A
Radiated Emission	Level Accuracy: 30MHz to 1000 MHz	± 4.40 dB	± 5.2 dB
Radiated Emission	Level Accuracy: Above 1000MHz	± 4.20 dB	N/A
Mains Harmonic	Voltage	$\pm 3.11\%$	N/A
Voltage Fluctuations & Flicker	Voltage	$\pm 3.25\%$	N/A

1.8. Test Facility

The testing report were performed by the Shenzhen Toby Technology Co., Ltd., in their facilities located at 1A/F., Bldg.6, Yusheng Industrial Zone, The National Road No.107 Xixiang Section 467, Xixiang, Bao'an, Shenzhen, Guangdong, China. At the time of testing, the following bodies accredited the Laboratory:

CNAS (L5813)

The Laboratory has been accredited by CNAS to ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories for the competence in the field of testing. And the Registration No.: CNAS L5813.

FCC List No.: (811562)

The Laboratory is listed in the United States of American Federal Communications Commission (FCC), and the registration number is 811562.

IC Registration No.: (11950A-1)

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing. The site registration: Site# 11950A-1.

2. TEST Results Summary

EMISSION		
Description of test items	Standards	Results
Conducted disturbance at mains terminals	EN 55032: 2015 Class B	N/A
Radiated Disturbance	EN 55032: 2015 Class B	Pass ⁽²⁾
Harmonic current emissions	EN 61000-3-2: 2014	N/A
Voltage fluctuation and flicker	EN 61000-3-3: 2013	N/A
IMMUNITY		
Description of test items	Standards	Results
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1:2008 +A2:2010	Pass
EFT/B Immunity	EN 61000-4-4: 2012	N/A
Surge Immunity	EN 61000-4-5: 2014	N/A
Conducted RF Immunity	EN 61000-4-6: 2014	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	N/A ⁽³⁾
Voltage dips, >95% reduction	EN 61000-4-11: 2004	N/A
Voltage dips, 30% reduction		
Voltage interruptions		
Note: N/A is an abbreviation for Not Applicable. (1) For Harmonic Current the equipment power is less than 75W. (2) The EUT maximum operating frequency is less than 108MHz, so no requirement for the radiated disturbance for above 1GHz. (3) Not applicable. the EUT has not magnetic field.		

3. Test Equipment Used

Radiation Emission Test					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
Spectrum Analyzer	Agilent	E4407B	MY45106456	Jul. 22, 2016	Jul. 21, 2017
EMI Test Receiver	Rohde & Schwarz	ESCI	100010/007	Jul. 22, 2016	Jul. 21, 2017
Bilog Antenna	ETS-LINDGREN	3142E	00117537	Mar. 20, 2016	Mar. 19, 2017
Horn Antenna	ETS-LINDGREN	3117	00143207	Mar. 19, 2016	Mar. 18, 2017
Pre-amplifier	Sonoma	310N	185903	Mar. 20, 2016	Mar. 19, 2017
Pre-amplifier	HP	8447B	3008A00849	Mar. 26, 2016	Mar. 25, 2017
Cable	HUBER+SUHNER	100	SUCOFLEX	Mar. 26, 2016	Mar. 25, 2017
Positioning Controller	ETS-LINDGREN	2090	N/A	N/A	N/A
Discharge Immunity Test					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
ESD Generator	HAFELY	PESD 1610	H808671	Mar.18, 2016	Mar.17, 2017
Radiated Immunity Test					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
Signal Generator	Rohde & Schwarz	SMT03	200754	Mar.26, 2016	Mar. 25, 2017
Power Meter	Rohde & Schwarz	NRVD	110562	Feb. 16, 2016	Feb. 15, 2017
Voltage Probe	Rohde & Schwarz	URV5-Z2	12056	Feb. 16, 2016	Feb. 15, 2017
Voltage Probe	Rohde & Schwarz	URV5-Z2	12074	Feb. 16, 2016	Feb. 15, 2017
RF Amplifier	AR	50S1G4A	326720	Feb. 16, 2016	Feb. 15, 2017
Bilog Antenna	ETS	3142C	00047662	Feb. 16, 2016	Feb. 15, 2017
Horn Antenna	ARA	DRG-118A	16554	Feb. 16, 2016	Feb. 15, 2017
Audio Analyzer	Rohde & Schwarz	UPL 16	SB2208	Feb. 16, 2016	Feb. 15, 2017
Sound Level Calibrator	B&K	4231	264516	Feb. 16, 2016	Feb. 15, 2017

4. Radiated Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

EN 55032: 2015 Class B

4.1.2. Test Limit

Bellow 1GHz

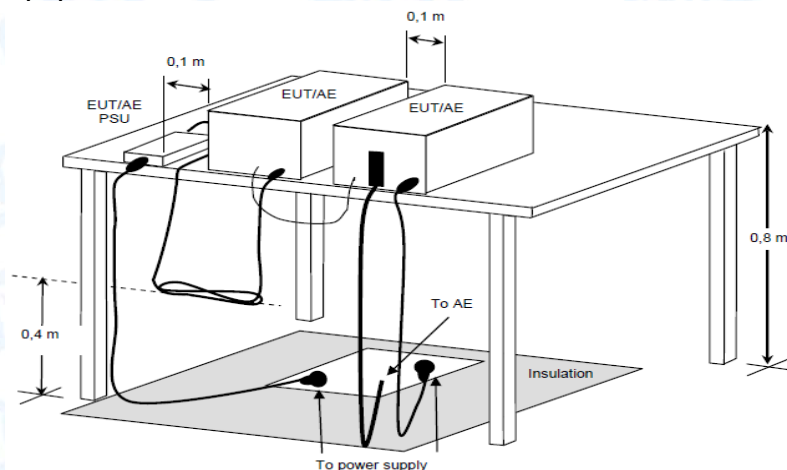
Frequency	Limit (dB μ V/m) (3m)	
	Quasi-peak Level	
	Class A	Class B
30MHz~230MHz	50	40
230MHz~1000MHz	57	47
Remark: 1. The lower limit shall apply at the transition frequency. 2. The test distance is 3m.		

Above 1GHz

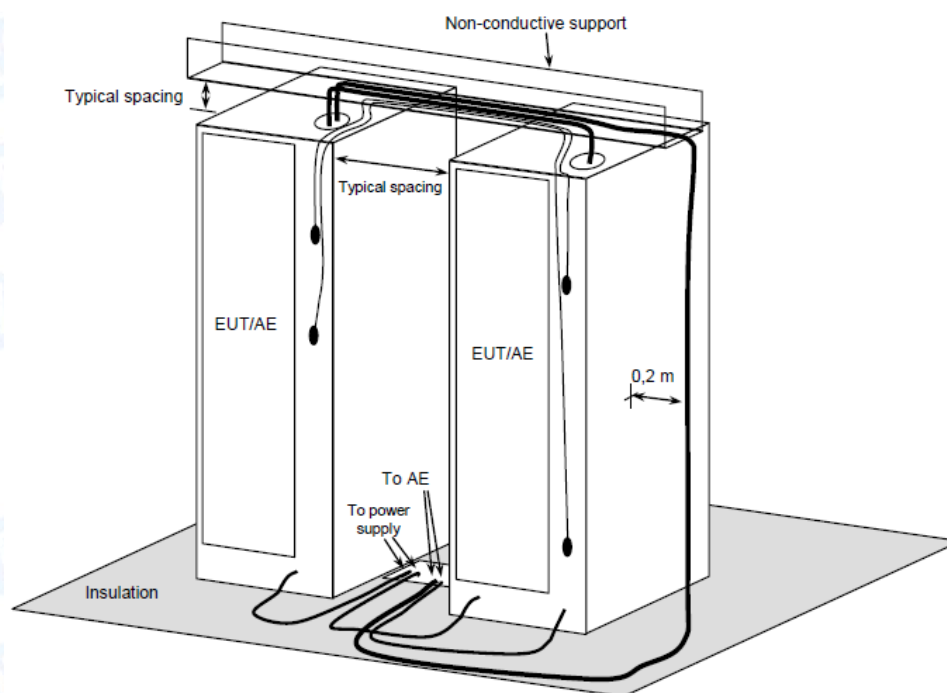
Frequency (GHz)	Limit (dB μ V/m) (3m)			
	Class A		Class B	
	Peak	Average	Peak	Average
1~3	76	56	70	50
3~6	80	60	74	54
Remark: 1. The lower limit shall apply at the transition frequency. 2. The test distance is 3m.				

4.2. Test Setup

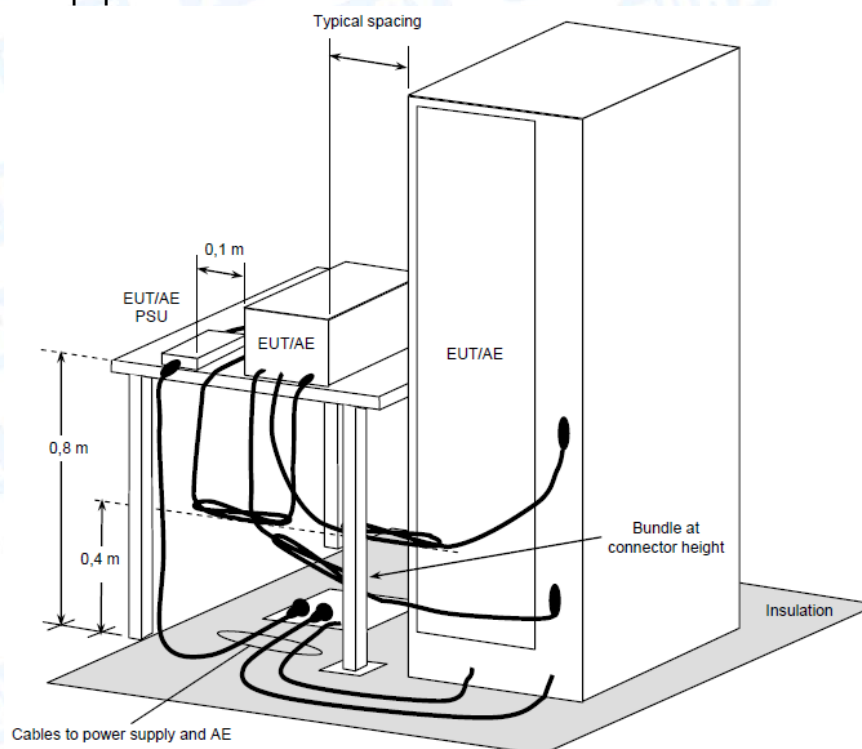
☒ For table top equipment



☐ For floor standing equipment



☐ For combination equipment



4.3. Test Procedure

Measurement was performed according to clause 7.3 of CISPR 16-2-3.

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

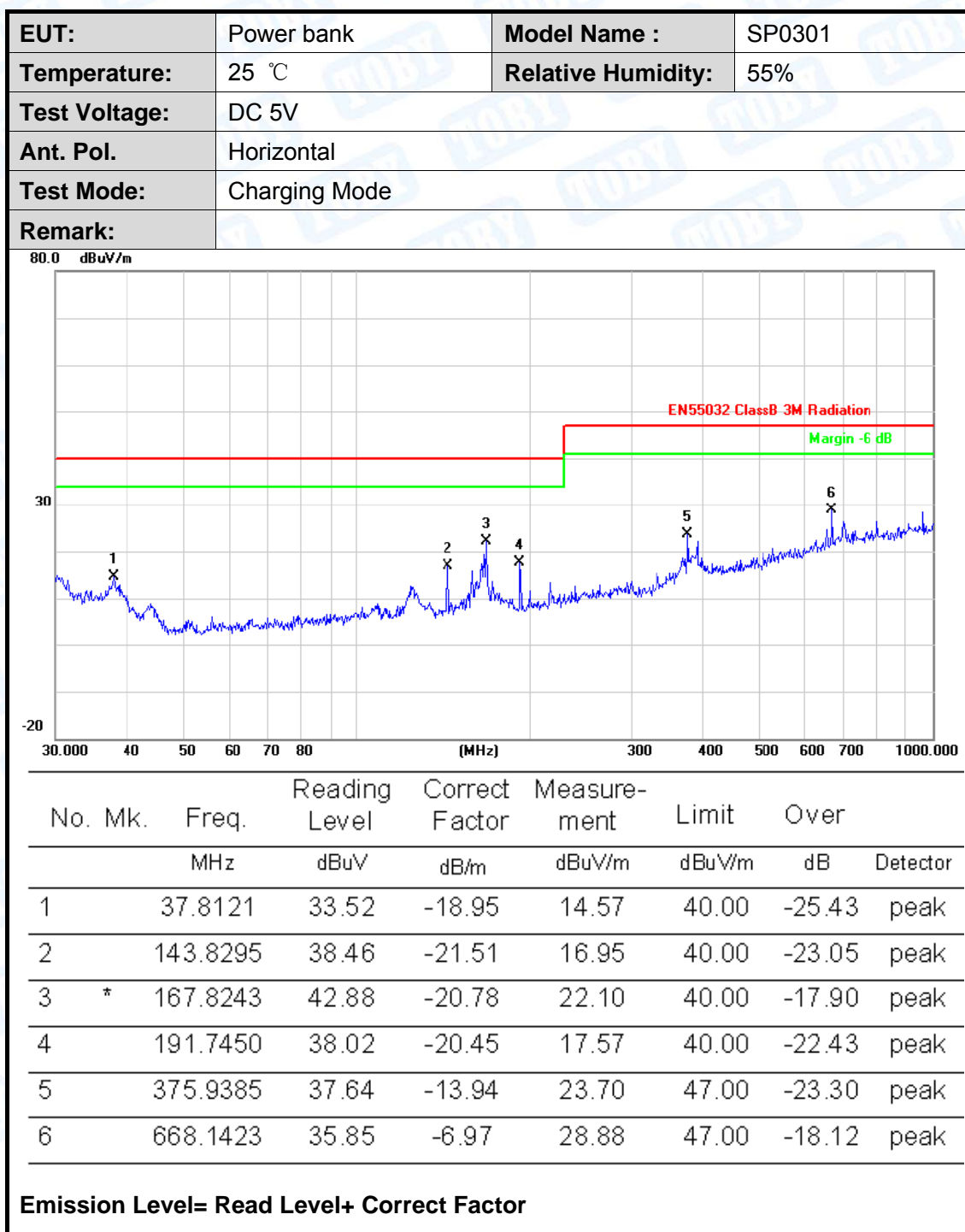
The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

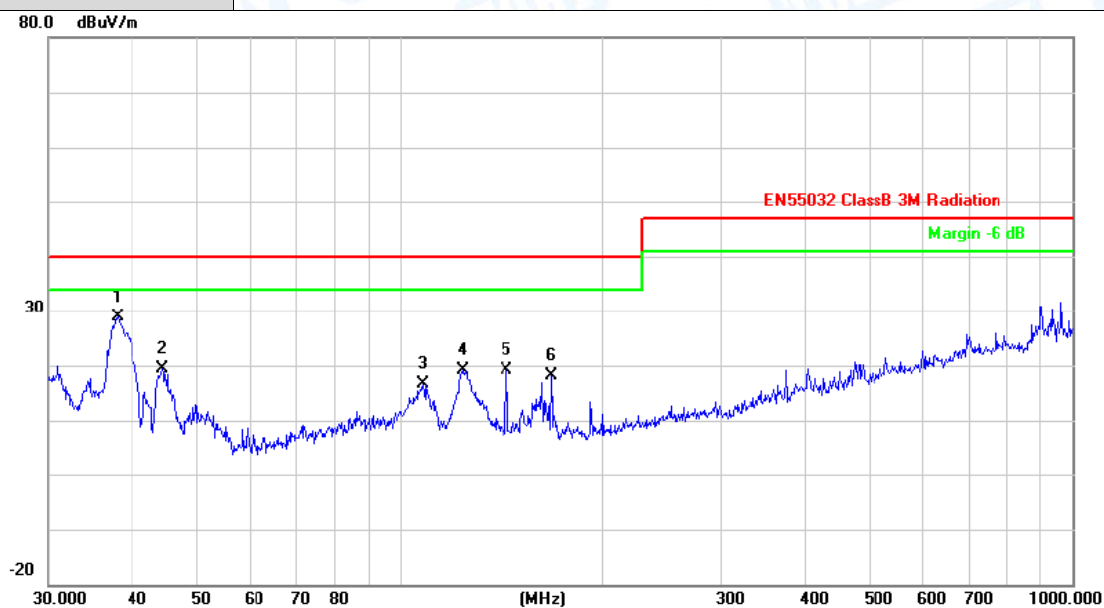
Highest internal frequency (Fx)	Highest measured frequency for radiated measurement	Measured Bandwidth
$F_x \leq 108 \text{ MHz}$	1 GHz	120kHz
$108 \text{ MHz} < F_x \leq 500 \text{ MHz}$	2 GHz	1MHz
$500 \text{ MHz} < F_x \leq 1 \text{ GHz}$	5 GHz	1MHz
$F_x > 1 \text{ GHz}$	5*Fx up to a maximum of 6 GHz	1MHz
NOTE 1: For FM and TV broadcast receivers, Fx is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies. NOTE 2: For outdoor units of home satellite receiving systems highest measured frequency shall be 18GHz.		

4.4. Test Data

Please refer to the following pages.



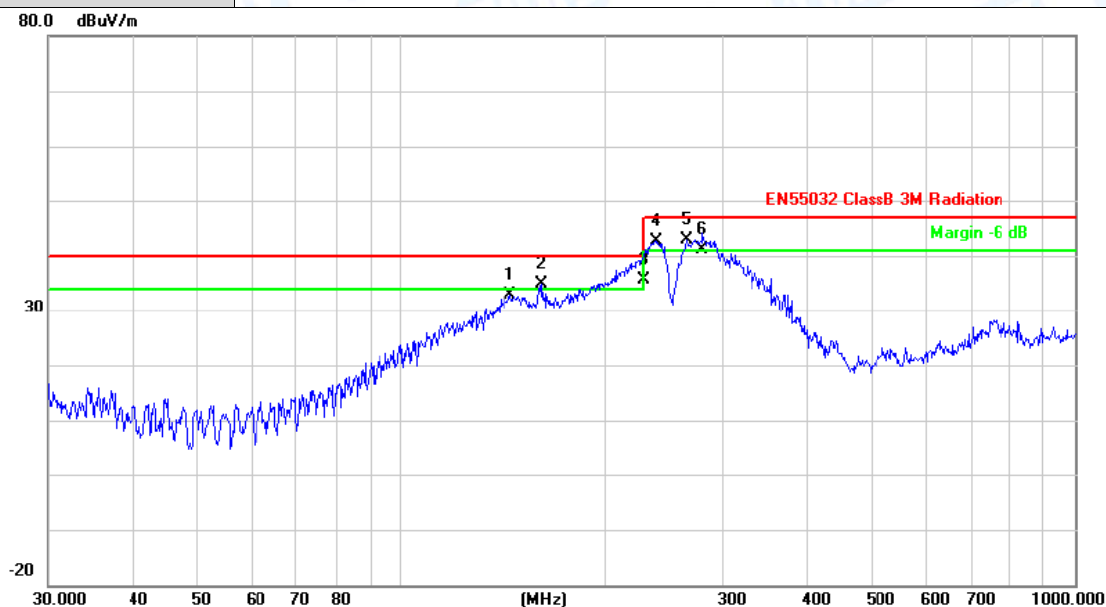
EUT:	Power bank	Model Name :	SP0301
Temperature:	25 °C	Relative Humidity:	55%
Test Voltage:	DC 5V		
Ant. Pol.	Vertical		
Test Mode:	Charging Mode		
Remark:			



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB/m	Measure- ment dBuV/m	Limit dBuV/m	Over dB	Detector
1	*	37.9450	47.87	-19.04	28.83	40.00	-11.17	peak
2		44.2752	41.44	-22.09	19.35	40.00	-20.65	peak
3		108.2667	38.46	-21.85	16.61	40.00	-23.39	peak
4		123.6985	41.43	-22.32	19.11	40.00	-20.89	peak
5		143.8295	40.58	-21.51	19.07	40.00	-20.93	peak
6		167.8243	38.94	-20.78	18.16	40.00	-21.84	peak

Emission Level= Read Level+ Correct Factor

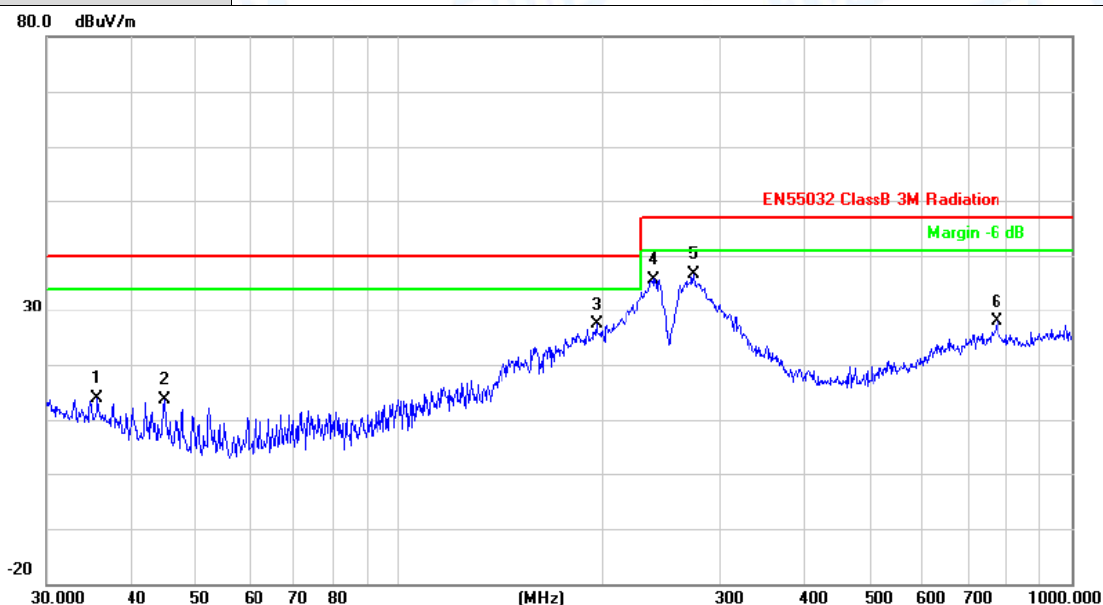
EUT:	Power bank	Model Name :	SP0301
Temperature:	25 °C	Relative Humidity:	55%
Test Voltage:	DC 5V		
Ant. Pol.	Horizontal		
Test Mode:	Discharging Mode		
Remark:			



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Detector
1		145.3506	54.20	-21.38	32.82	40.00	-7.18	peak
2	!	162.0414	55.19	-20.41	34.78	40.00	-5.22	peak
3	!	229.2931	54.35	-18.70	35.65	40.00	-4.35	QP
4	!	239.1473	60.95	-18.23	42.72	47.00	-4.28	peak
5	*	265.6757	60.35	-17.36	42.99	47.00	-4.01	peak
6	!	280.0237	58.18	-17.05	41.13	47.00	-5.87	QP

Emission Level= Read Level+ Correct Factor

EUT:	Power bank	Model Name :	SP0301
Temperature:	25 °C	Relative Humidity:	55%
Test Voltage:	DC 5V		
Ant. Pol.	Vertical		
Test Mode:	Discharging Mode		
Remark:			



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB Detector
1		35.6240	31.52	-17.61	13.91	40.00	-26.09 peak
2		44.9006	36.05	-22.35	13.70	40.00	-26.30 peak
3		196.5098	47.60	-20.19	27.41	40.00	-12.59 peak
4		239.1473	53.98	-18.23	35.75	47.00	-11.25 peak
5	*	274.1939	53.72	-17.18	36.54	47.00	-10.46 peak
6		774.1584	33.34	-5.58	27.76	47.00	-19.24 peak

Emission Level= Read Level+ Correct Factor

5. Electrostatic Discharge Immunity Test

5.1. Test Requirements

5.1.1. Test Standard

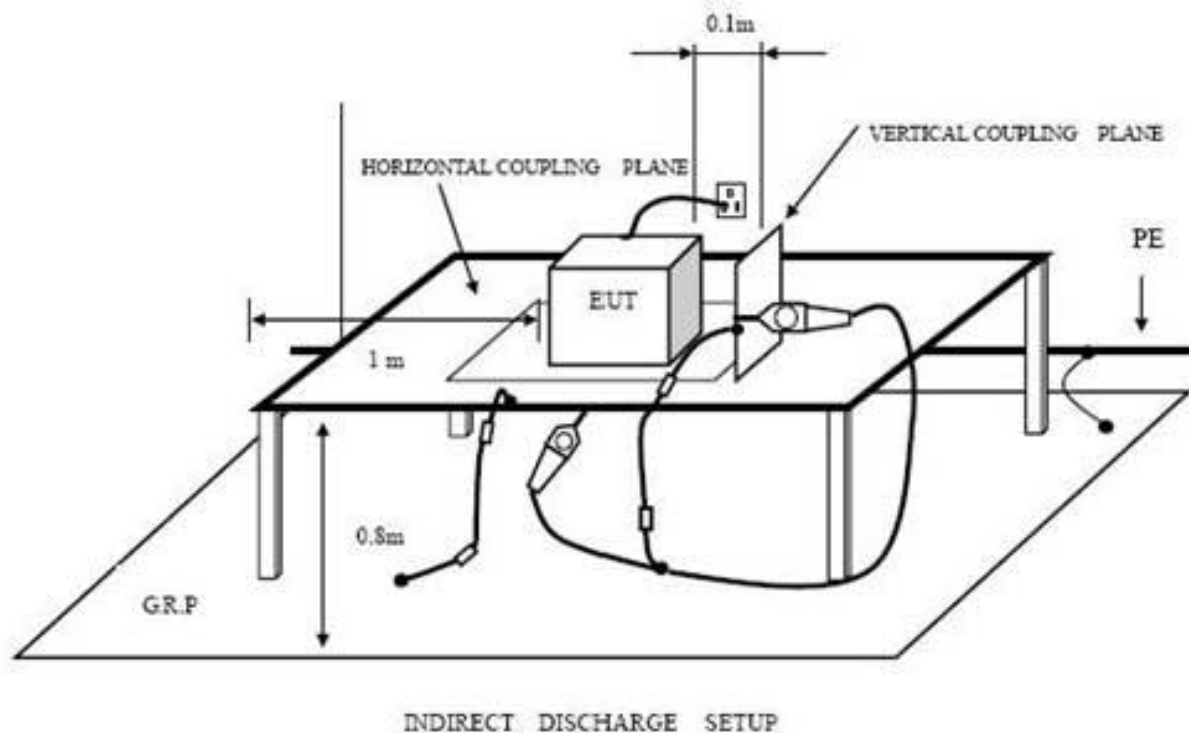
EN 55024:2010+A1: 2015 (EN 61000-4-2:2009)

5.1.2. Test Level

Discharge Impedance:	330 ohm/ 150pF
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV(Direct) Contact Discharge: 2kV/4kV (Direct /Indirect)
Polarity:	Positive& Negative
Number of Discharge:	Air Discharge: min.20 times at each test point Contact Discharge: min.200 times in total
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

5.1.3. Performance criterion: B

5.2. Test Setup



5.3. Test Procedure

5.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

5.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.4. Test Data

Please refer to the following pages.

Electrostatic Discharge Test Result

EUT	: Power bank	M/N	: SP0301
Temperature	: 22°C	Humidity	: 50%
Power supply	: DC 5V	Test Mode	: Mode 1/2
Criterion: B			
Air Discharge: $\pm 2/\pm 4/\pm 8$ kV Contact Discharge: $\pm 2/\pm 4$ kV			
For each point positive 10 times and negative 10 times discharge.			
Location	Kind A-Air Discharge C-Contact Discharge	Result	
Nonconductive Enclosure	A	PASS	
Slot of the EUT	A	PASS	
USB Port	A	PASS	
HCP	C	PASS	
VCP of front	C	PASS	
VCP of rear	C	PASS	
VCP of left	C	PASS	
VCP of right	C	PASS	
Note:			
1) Criteria A: There was no change operated with initial operating during the test.			
2) Criteria B: The EUT function loss during the test, but self-recoverable after the test.			
3) Criteria C: The system shut down during the test.			

6. Radiated Electromagnetic Field Immunity Test

6.1. Test Requirements

6.1.1. Test Standard

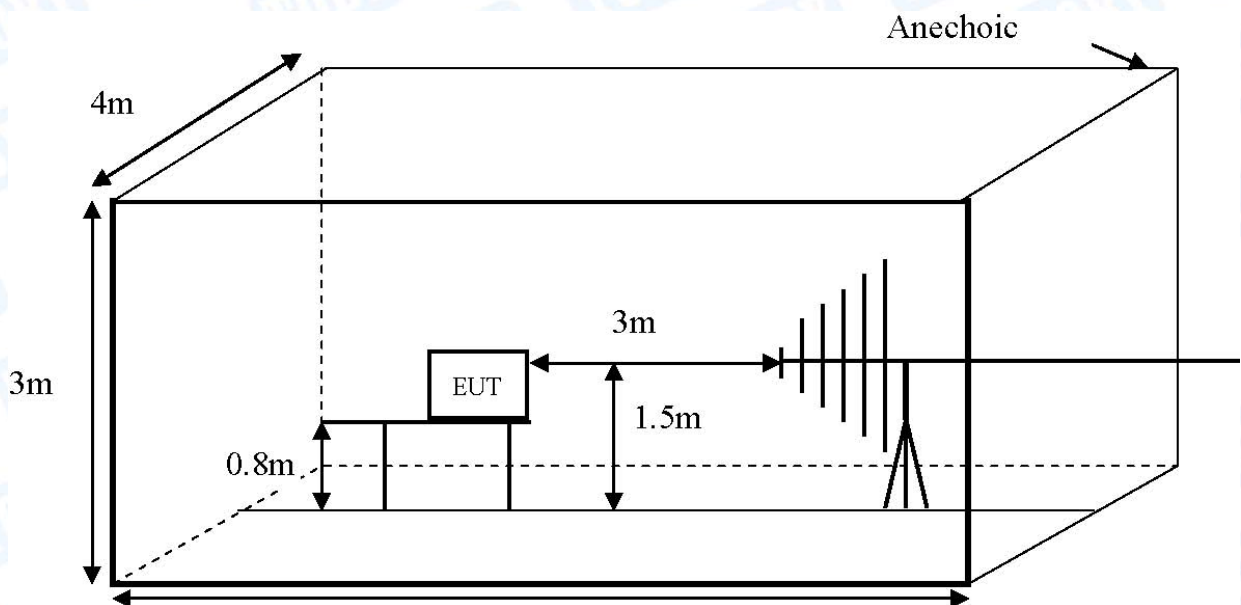
EN 55024:2010+A1: 2015 (EN 61000-4-3:2006+A1:2008+A2:2010)

6.1.2. Test Level

Port	Test Specification
Enclosure Port	80-1000MHz 3 V/m 80 % AM (1kHz)

6.1.3. Performance criterion: A

6.2. Test Setup



6.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
Fielded strength	3V/m (Severity Level 2)
Radiated signal	Modulated
Scanning frequency	80-1000MHz
Sweep time of radiated	0.0015 Decade/s
Dwell time	1 Sec.

6.4. Test Data

Please refer to the following pages.

RF Field Strength Susceptibility Test Results

EUT	: Power bank	M/N	: SP0301
Temperature	: 22°C	Humidity	: 50%
Power supply	: DC 5V	Test Mode	: Mode 1/2

Required Performance Criteria: A

Modulation: AM 80%

Pulse: 1 kHz

EUT Position	Actual Performance Criteria				Judgment
	Frequency Range 1: 80~1000MHz		Frequency Range 2: /		
	Horizontal	Vertical	Horizontal	Vertical	
Front	A	A	/	/	PASS
Right	A	A	/	/	PASS
Rear	A	A	/	/	PASS
Left	A	A	/	/	PASS

Remark:

- 1) Criteria A: There was no change operated with initial operating during the test.
- 2) Criteria B: The EUT function loss during the test, but self-recoverable after the test.
- 3) Criteria C: The system shut down during the test.

7. Photographs - Constructional Details

Photo 1 Appearance of EUT



Photo 2 Appearance of EUT



Photo 3 Internal of EUT



Photo 4 Appearance of PCB

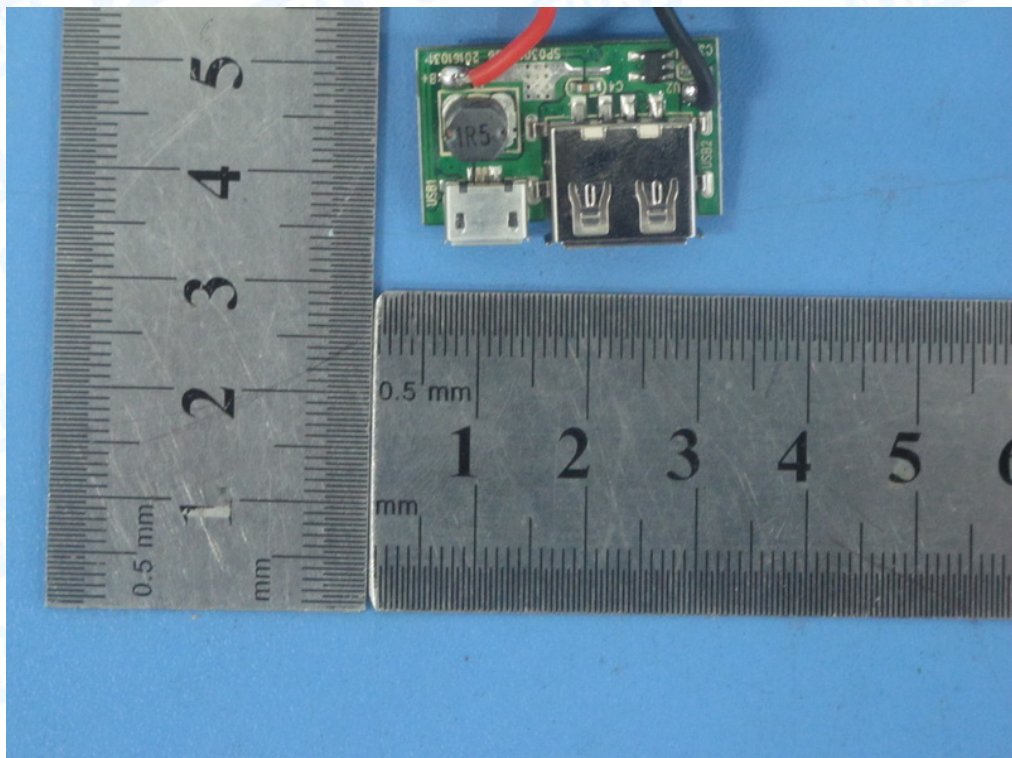
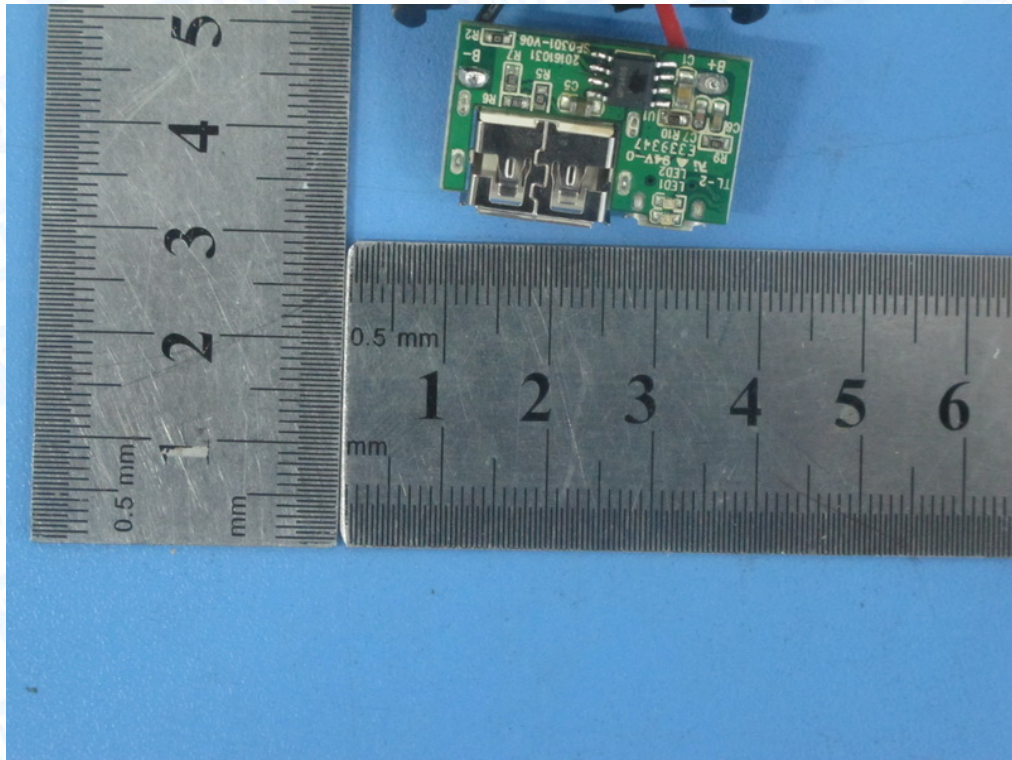


Photo 5 Appearance of PCB



8. Photographs – Test Setup

Photo 1 Radiated Emission Test Setup



Photo 2 Radiated Emission Test Setup

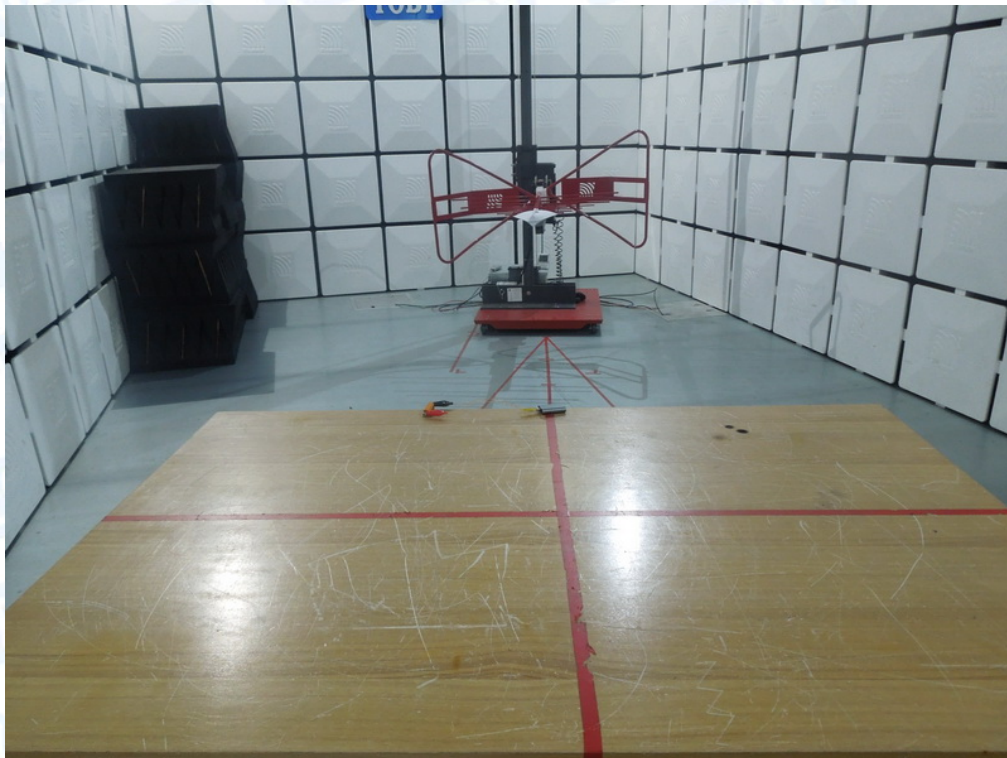


Photo 3 Electrostatic Discharge Test Setup



Photo 4 Electrostatic Discharge Test Setup



-----END OF REPORT-----